

Issue Classification



Application/Control No.

10065665

Applicant(s)/Patent under Reexamination

BU ET AL.

Examiner

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Art Unit

2629

ORIGINAL

CLASS

345

SUBCLASS

98

INTERNATIONAL CLASSIFICATION

CLAIMED

3 / 36

NON-CLAIMED

CROSS REFERENCE(S)

CLASS

345

87

89

90

94

100

SUBCLASS (ONE SUBCLASS PER BLOCK)

204

212

214

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(Assistant Examiner)

06/08/2006

(Date)

Total Claims Allowed:

36

28

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6/14/06

(Date)

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6/12/06

O.G.

Print Claim(s)

O.G.

Print Figure

1

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